Applications

Mb Ethernet port protection

- Gb Ethernet port protection
- Isolated and floating interfaces

P650-U and P850-U Series TBU® High-Speed Protectors

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3

200 mA/div.

Operational Characteristics

The graphs below demonstrate the operational characteristics of the TBU® protector. For each graph the fault voltage, protected side voltage, and current is presented.



P650-U Power Fault, 120 Vrms, 25 A



P850-U Power Fault, 230 Vrms, 25 A



Specifications are subject to change without notice.

The device characteristics and parameters in this data sheet can and do vary in different applications and actual device performance may vary over time. Users should verify actual device performance in their specific applications.

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Product Dimensions





NC = Solder to PCB; do not make electrical connection, do not connect to ground.

Ν

ΝJ

TBU[®] devices have matte-tin termination finish. Suggested layout should use non-solder mask define (NSMD). Recommended stencil thickness is 0.10-0.12 mm (.004-.005 in.) with stencil opening size 0.025 mm (.0010 in.) less than the device pad size. As when heat sinking any power device, it is recommended that, wherever possible, extra PCB copper area is allowed. For minimum parasitic capacitance, do not allow any signal, ground or power signals beneath any of the pads of the device.

Thermal Resistances			
Symbol	Parameter	Value	Unit
Rth(j-a)	Junction to leads (package)	105	°C/W
	Junction to leads (per TBU® device)	202	°C/W

Max. Dim. Min. Тур. 6.25 6.15 6.35 А (.242) (.246) (.250) 7.65 7.75 7.85 В (.301)(.305)(.309)0.80 0.85 0.90 С (.031)(.033)(.035)0.000 0.025 0.050 D (.000)(.001)(.002)0.50 0.55 0.60 E (.020)(.022)(.024)1.20 1.25 1.30 F (.047)(.049) (.051)4.20 4.25 4.30 G (.165) (.169) (.167) 2.55 2.45 2.50 Н (.096)(.098)(.100)0.20 0.25 0.30 J (.008)(.010)(.012)0.50 0.55 0.45 Κ (.018)(.020)(.022)0.75 0.65 0.70 L (.026) (.028) (.030) 0.20 0.25 0.30 Ν (.008) (.010)(.012) 0.70 0.75 0.80 Р (.028)(.030) (.031)<u>3.30</u> (.130) 3.20 3.25 Q (.126) (.128)

DIMENSIONS: $\frac{MM}{(INCHES)}$

Block Diagram



Reflow Profile

Profile Feature	Pb-Free Assembly		
Average Ramp-Up Rate (Tsmax to Tp)	3 °C/sec. max.		
Preheat			
- Temperature Min. (Tsmin)	150 °C		
- Temperature Max. (Tsmax)	200 °C		
- Time (tsmin to tsmax)	60-180 sec.		
Time maintained above:			
- Temperature (TL)	217 °C		
- Time (tL)	60-150 sec.		
Peak/Classification Temperature (Tp)	260 °C		
Time within 5 °C of Actual Peak Temp. (tp)	20-40 sec.		
Ramp-Down Rate	6 °C/sec. max.		
Time 25 °C to Peak Temperature	8 min. max.		



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(INCHES)



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Reference Applications

A cost-effective protection solution utilizes the Bourns® TBU® protection devices. The diagrams below illustrate common configurations of these components. The graph at the bottom demonstrates the operational characteristics of the circuit.



Typical Configuration Diagrams



GbE Ethernet Protection Up to 1500 V Common-Mode Lightning Protection



P850-U with G5200AS 4000 V Lightning 10/700 µsec, 150 A

GbE Ethernet Protection Up to 6000 V Common-Mode Lightning Protection



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